## **\$**01.70367 PATENT APPLICATION IN THE UNITED STATES PATENT AND TRADEMARK OFFICE FW Nayfeh et al. icant: I hereby certify that this paper is being deposited with the ) rial No.: 10/829,486 United States Postal Service as FIRST-CLASS mail in an envelope addressed to: Mail Stop AMENDMENT, Filed: April 22, 2004 Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450, on this date. Conf. No.: 6925 For: FAMILY OF DISCRETELY April 8, 2005 Attorney for Applicants SIZED SILICON Date Registration No. 43,874 NANOPARTICLES AND METHOD FOR PRODUCING THE SAME 1754 Art Unit:

## SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT

Dear Sir:

Examiner:

This IDS is submitted under 37 C.F.R. §1.97(c), after the C.F.R. §1.97(b) time period, but before the mail date of a Final Office Action or a Notice of Allowance (whichever occurs first), with either:

(a) a statement under 37 C.F.R. §1.97(e); or

Medina Sanabria, Maribel

(b) the \$180.00 fee under 37 C.F.R. §1.17(p).

Applicant(s) submit herewith Form PTO-1449 (Information Disclosure Citation) together with copies of patents, publications or other information of which applicant(s) are aware, which applicant(s) believe may be material to the examination of this application and for which there may be a duty to disclose in accordance with 37 C.F.R. §1.56. Applicant(s) respectfully submit that the citation of any reference on Form PTO-1449 does not constitute an admission that the reference qualifies as prior art.

It is requested that the information disclosed on the enclosed Form PTO-1449 be made of record in this application.

- (X) Statement Under 37 C.F.R. §1.97(e):
  - (X) The enclosed references were cited in a Communication issued by a foreign Patent Office (copy enclosed). Applicant(s) hereby certify that each item of information cited on the enclosed Form PTO-1449 was first cited in any communication from a foreign patent office in a counterpart foreign application not more than three (3) months prior to the filing of this Information Disclosure Statement.
  - ( ) Applicant(s) hereby certify that no item of information cited on the enclosed Form PTO-1449 was cited in a communication from a foreign patent office in a counterpart foreign application, and, to the knowledge of the person signing below after making reasonable inquiry, no item of information cited on the enclosed Form PTO-1449 was known to any individual designated in §1.56(c) more than three months prior to the filing of this Information Disclosure Statement.
- ( ) Enclosed is a check for \$180.00 to cover the fee as set forth in 37 C.F.R. § 1.17(p).

The Commissioner is hereby authorized to charge any additional fees which may be required to this application under 37 C.F.R. §§1.16-1.17, or to credit any overpayment, to Deposit Account No. 07-2069. A duplicate copy of this sheet is enclosed.

Customer No. 24978 April 8, 2005 300 South Wacker Drive Suite 2500 Chicago, Illinois 60606 Telephone: (312)

Telephone: (312) 360-0080 Facsimile: (312) 360-9315 P:\DOCS\1201\70367\903464.DOC Respectfully submitted, GREER, BURNS & CRAIN, LTD.

Arik B. Ranson, Reg. No. 43,874

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